

**Search Notes**

Application/Control No.

10/616,228

Examiner

Pablo Whaley

Applicant(s)/Patent under  
Reexamination

CHEE ET AL.

Art Unit

1631

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Google Scholar: base calling, ratio, DNA, intensity, probe, mutation	6/21/2007	PW
EAST: See attached	6/21/2007	PW